

**Search Notes**

Application/Control No.

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Examiner

Khai M. Nguyen

Applicant(s)/Patent under  
Reexamination

HAN ET AL.

Art Unit

2617

**SEARCHED**

Class	Subclass	Date	Examiner
see	previous		KN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
see previous		KN